Silicon P Channel MOS FET High Speed Power Switching

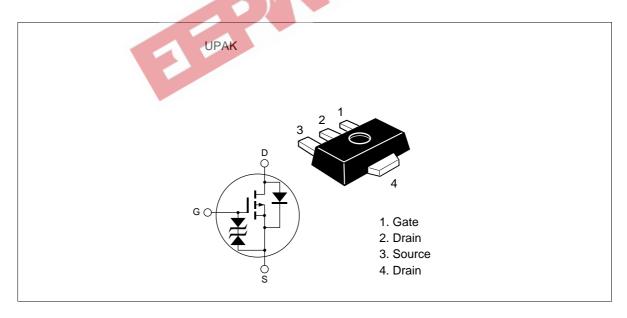
HITACHI

ADE-208-580B (Z) 3rd. Edition Jun 1998

Features

- Low on-resistance $R_{DS(on)} = 0.35~\Omega~typ.~at~(V_{GS} = -10V,~I_D = -1A)$
- Low drive current
- 4 V gete drive devices
- High speed switching

Outline





Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{\scriptscriptstyle DSS}$	-60	V
Gate to source voltage	$V_{\rm GSS}$	±20	V
Drain current	I _D	-2	A
Drain peak current	Note1 D(pulse)	-4	A
Body-drain diode reverse drain current	I _{DR}	-2	A
Avalenche current	I _{AP} Note2	-2	A
Avalenche energy	E _{AR}	0.34	mJ
Channel dissipation	Pch Note3	1	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Note: 1. PW \leq 10 μ s, duty cycle \leq 1 %

2. value at Tch = 25°C, Rg \geq 50 Ω

3. Value at when using the aluminaceramic board (12.5x20x0.7mm)

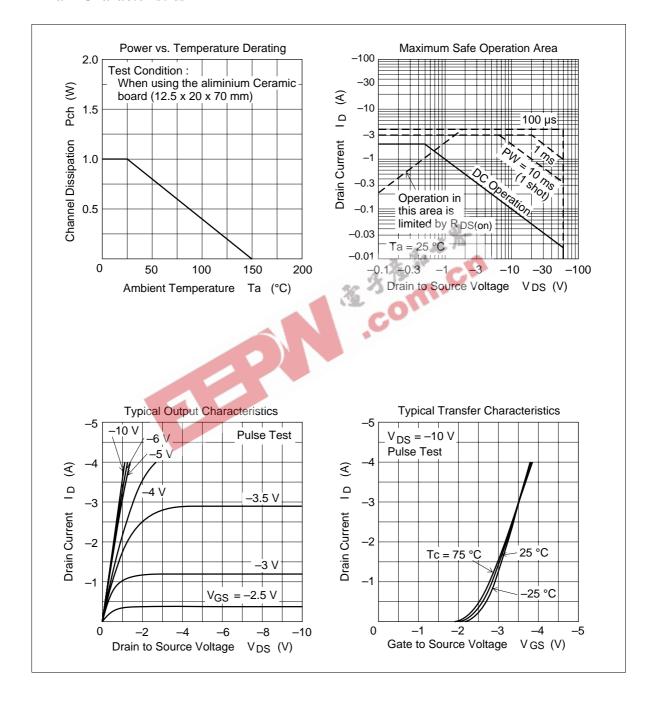
Electrical Characteristics ($Ta = 25^{\circ}C$)

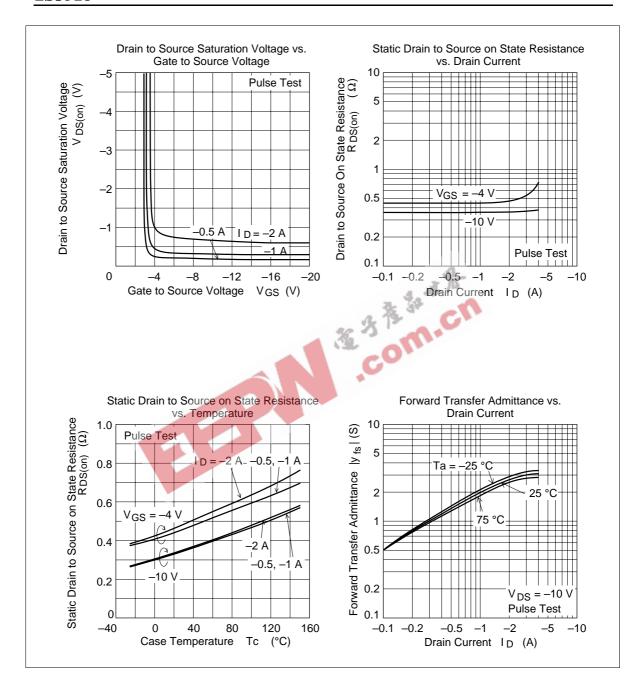
Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	V _{(BR)DSS}	-60	_	_	V	$I_{D} = -10 \text{mA}, V_{GS} = 0$
Gate to source breakdown voltage	V _{(BR)GSS}	±20	_	_	V	$I_{G} = \pm 100 \mu A, V_{DS} = 0$
Zero gate voltege drain current	I _{DSS}	_	_	-10	μΑ	$V_{DS} = -60 \text{ V}, V_{GS} = 0$
Gate to source leak current	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-1.0	_	-2.0	V	$I_{D} = -1 \text{mA}, V_{DS} = -10 \text{V}$
Static drain to source on state	$R_{\scriptscriptstyle DS(on)}$	_	0.35	0.46	Ω	$I_{\rm D} = -1A, \ V_{\rm GS} = -10V^{\rm Note4}$
resistance	R _{DS(on)}	_	0.45	0.63	Ω	$I_{\rm D} = -1A, \ V_{\rm GS} = -4V^{\rm Note4}$
Forward transfer admittance	y _{fs}	1.2	2.0	_	S	$I_{\rm D} = -1A, \ V_{\rm DS} = -10V^{\rm Note4}$
Input capacitance	Ciss	_	220	_	pF	V _{DS} = -10V
Output capacitance	Coss	_	110	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	35	_	pF	f = 1MHz
Turn-on delay time	t _{d(on)}	_	10	_	ns	$V_{GS} = -10V, I_{D} = -1A$
Rise time	t _r	_	11	_	ns	$R_L = 30\Omega$
Turn-off delay time	t _{d(off)}	_	45	_	ns	_
Fall time	t _f	_	30	_	ns	_
Body-drain diode forward voltage	V_{DF}	_	-1.05	_	V	$I_{D} = -2A, V_{GS} = 0$
Body-drain diode reverse recovery time	t _{rr}	_	50	_	ns	$I_F = -2A$, $V_{GS} = 0$ diF/ dt = 50A/ μ s

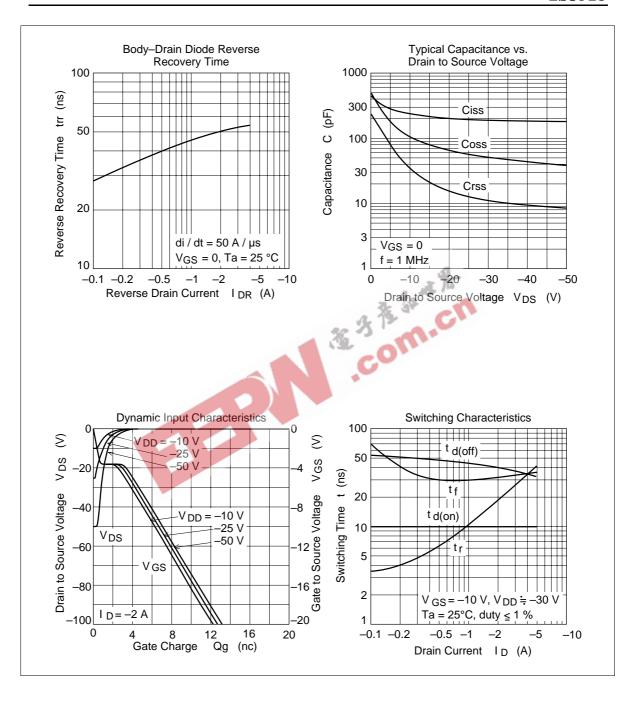
Note: 4. Pulse test

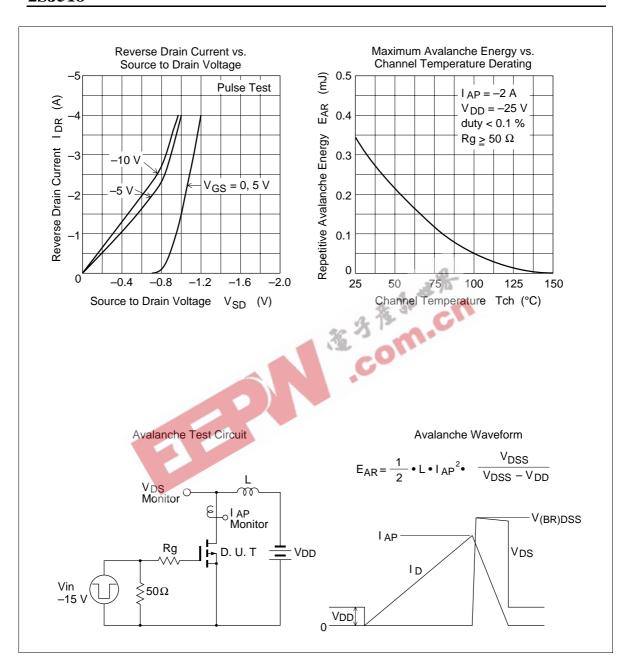
5. Marking is "AZ"

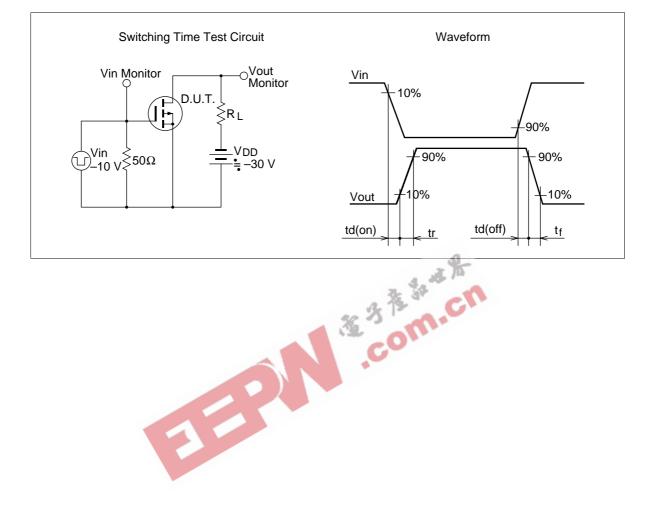
Main Characteristics





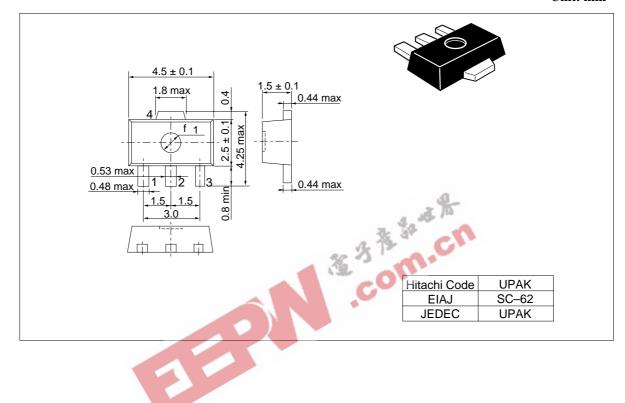






Package Dimensions

Unit: mm



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